

N-Channel 100 V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | |
|---------------------|--------------------------------------|---------------------------------|-----------------------|--|--|
| V _{DS} (V) | $R_{DS(on)}\left(\Omega\right)$ Max. | I _D (A) ^a | Q _g (Typ.) | | |
| | 0.012 at V _{GS} = 10 V | 48 | | | |
| 100 | 0.014 at V _{GS} = 7.5 V | 38 | 13.9 nC | | |
| | 0.028 at V _{GS} = 4.5 V | 34 | | | |

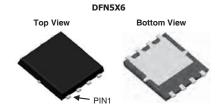
FEATURES

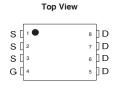
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R_q and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

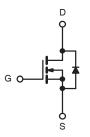


APPLICATIONS

- DC/DC Primary Side Switch
- Telecom/Server 48 V, Full/Half-Bridge DC/DC
- Industrial







N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS | S (T _A = 25 °C, unle | ess otherwise r | noted) | | |
|---|--|-----------------|----------------------|----|--|
| Parameter | Symbol | Limit | Unit | | |
| Drain-Source Voltage | V _{DS} | 100 | V | | |
| Gate-Source Voltage | V _{GS} | ± 20 | V | | |
| | T _C = 25 °C | | 48 | | |
| Continuous Drain Current (T _{.1} = 150 °C) | T _C = 70 °C | I _D | 32 | | |
| Continuous Brain Guirent (1) = 130 C) | T _A = 25 °C | | 13.3 ^{b, c} | | |
| | T _A = 70 °C | | 10.6 ^{b, c} | Α | |
| Pulsed Drain Current (t = 300 μs) | | I _{DM} | 180 | ^ | |
| Continuous Source-Drain Diode Current | T _C = 25 °C | I. | 40 | | |
| Continuous Source-Diam Diode Current | T _A = 25 °C | · Is | 4.5 ^{b, c} | | |
| Single Pulse Avalanche Current | L = 0.1 mH | I _{AS} | 30 | | |
| Single Pulse Avalanche Energy | L=0.1 IIII | E _{AS} | 50 | mJ | |
| | T _C = 25 °C | | 54.5 | | |
| Maximum Power Dissipation | T _C = 70 °C | P _D | 21.5 | w | |
| Maximum Fower Dissipation | T _A = 25 °C | 1 'D | 5 ^{b, c} | VV | |
| | T _A = 70 °C | 1 | 3.2 ^{b, c} | | |
| Operating Junction and Storage Temperature Ra | T _J , T _{stg} | - 55 to 150 | °C | | |
| Soldering Recommendations (Peak Temperature | | 260 | | | |

| THERMAL RESISTANCE RATINGS | | | | | | | |
|---|--------------|-------------------|---------|---------|-------|--|--|
| Parameter | | Symbol | Typical | Maximum | Unit | | |
| Maximum Junction-to-Ambient ^{b, f} | t ≤ 10 s | R _{thJA} | 20 | 25 | °C/W | | |
| Maximum Junction-to-Case (Drain) | Steady State | R_{thJC} | 2.1 | 2.8 | C/ VV | | |

Notes:

- a. Based on T_C = 25 °C.
 b. Surface mounted on 1" x 1" FR4 board.
- d. The DFN5X6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 70 °C/W.

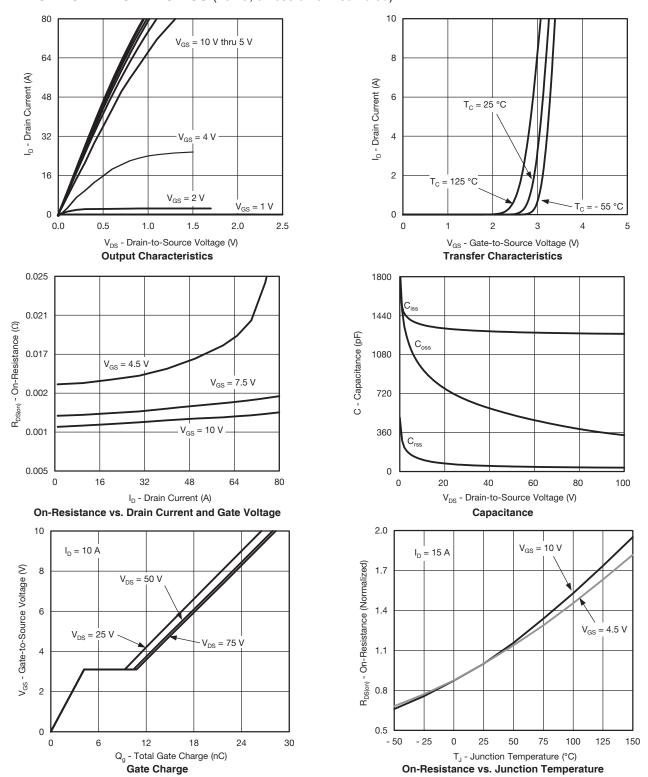
DTQ6008 www.din-tek.jp

| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit |
|--|-----------------------|---|------|-------|-------|----------|
| Static | - | | | | ! | <u>!</u> |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0$, $I_D = 250 \mu A$ | 100 | | | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | _S /T _J I _D = 250 μA | | 64 | | mV/°C |
| $V_{\rm GS(th)}$ Temperature Coefficient $\Delta V_{\rm GS(th)}$ | | J _D = 250 μA | | - 5.8 | | IIIV/ C |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_D = 250 \mu A$ | 1.2 | | 2.8 | V |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ | | | ± 100 | nA |
| Zava Cata Valta va Dvain Cuvvant | I _{DSS} | V _{DS} = 100 V, V _{GS} = 0 V | | | 1 | μΑ |
| Zero Gate Voltage Drain Current | | $V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$ | | | 10 | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$ | 30 | | | Α |
| | | V _{GS} = 10 V, I _D = 15 A | | 0.012 | 0.014 | Ω |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | V _{GS} = 7.5 V, I _D = 12 A | | 0.014 | 0.016 | |
| | | $V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$ | | 0.028 | 0.031 | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = 10 V, I _D = 15 A | | 44 | | S |
| Dynamic ^b | | | | 1 | 1 | |
| Input Capacitance | C _{iss} | | | 1275 | | |
| Output Capacitance | C _{oss} | $V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | | 500 | | pF |
| Reverse Transfer Capacitance | C _{rss} | | | 38 | | |
| · · | Qg | V _{DS} = 50 V, V _{GS} = 10 V, I _D = 10 A | | 27.9 | 42 | nC |
| Total Gate Charge | | $V_{DS} = 50 \text{ V}, V_{GS} = 7.5 \text{ V}, I_{D} = 10 \text{ A}$ | | 21.6 | 33 | |
| | | | | 13.9 | 21 | |
| Gate-Source Charge | Q _{gs} | $V_{DS} = 50 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$ | | 4.2 | | |
| Gate-Drain Charge | Q _{gd} | | | 6.3 | | |
| Output Charge | Q _{oss} | V _{DS} = 50 V, V _{GS} = 0 V | | 40 | 60 | |
| Gate Resistance | R_g | f = 1 MHz | 0.2 | 1.05 | 2.1 | Ω |
| Turn-On Delay Time | t _{d(on)} | | | 10 | 20 | |
| Rise Time | t _r | $V_{DD} = 50 \text{ V}, R_L = 5 \Omega$ | | 11 | 22 | - ns |
| Turn-Off Delay Time | t _{d(off)} | $I_D\cong$ 10 A, V_{GEN} = 10 V, R_g = 1 Ω | | 25 | 50 | |
| Fall Time | t _f | | | 8 | 16 | |
| Turn-On Delay Time | t _{d(on)} | | | 12 | 24 | |
| Rise Time | t _r | $V_{DD} = 50 \text{ V}, R_L = 5 \Omega$ | | 13 | 26 | |
| Turn-Off Delay Time | t _{d(off)} | $I_D\cong 10$ A, $V_{GEN}=7.5$ V, $R_g=1$ Ω | | 25 | 50 | |
| Fall Time | t _f | | | 8 | 16 | |
| Drain-Source Body Diode Characteristic | s | | | | • | |
| Continuous Source-Drain Diode Current | I _S | T _C = 25 °C | | | 40 | А |
| Pulse Diode Forward Current ^a | I _{SM} | | | | 180 | A |
| Body Diode Voltage | V_{SD} | I _S = 4 A | | 0.76 | 1.1 | V |
| Body Diode Reverse Recovery Time | t _{rr} | | | 36 | 70 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | I _F = 10 A, dl/dt = 100 A/µs, T _{.I} = 25 °C | | 38 | 76 | nC |
| Reverse Recovery Fall Time | t _a | i _F = 10 A, αί/αι = 100 A/μs, 1 _J = 25 °C | | 22 | | ns |
| Reverse Recovery Rise Time | t _b | | | 14 | | |

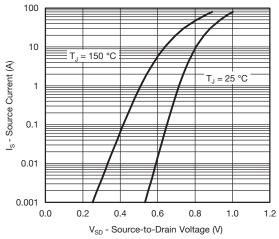
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

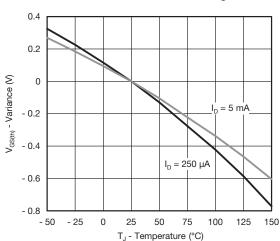




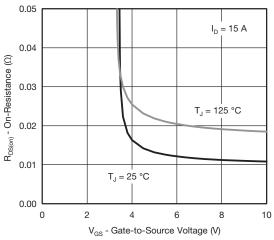




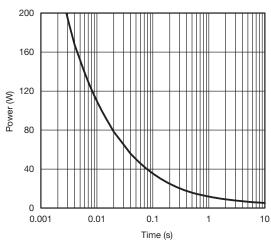
Source-Drain Diode Forward Voltage



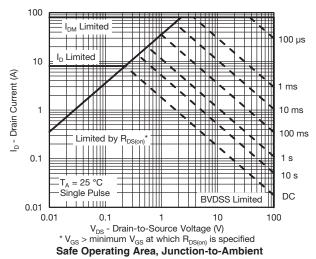
Threshold Voltage



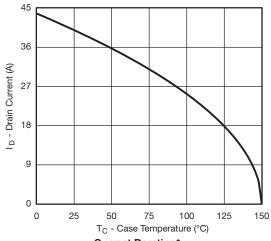
On-Resistance vs. Gate-to-Source Voltage



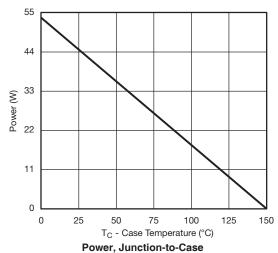
Single Pulse Power, Junction-to-Ambient

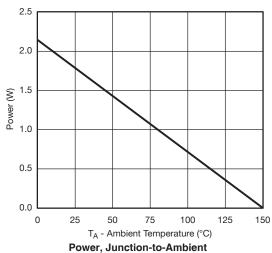






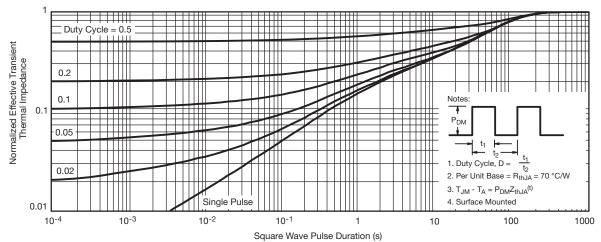




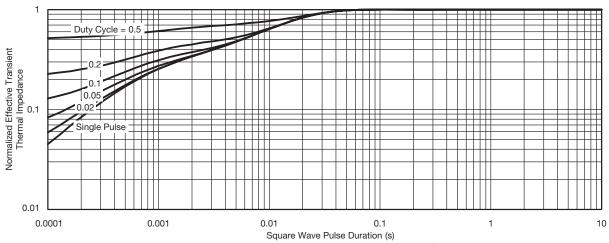


^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





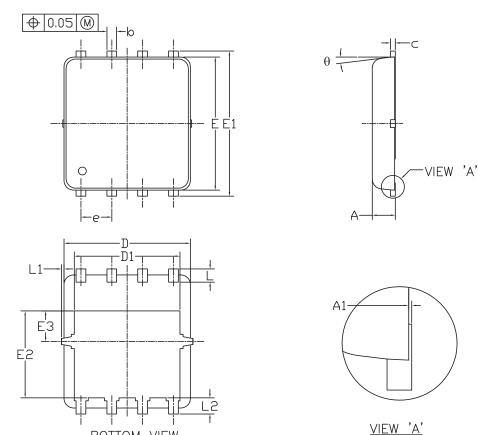
Normalized Thermal Transient Impedance, Junction-to-Ambient

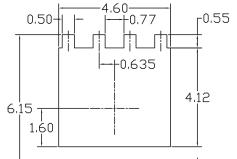


Normalized Thermal Transient Impedance, Junction-to-Case

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DFN5x6_8L_EP1_P PACKAGE OUTLIN





RECOMMENDED LAND PATTERN

| SYMBOLS | DIMENSIONS IN MILLIMETERS | | | DIMENSIONS IN INCHES | | | |
|---------|---------------------------|--------|--------|----------------------|--------|--------|--|
| | MIN | NOM | MAX | MIN | NOM | MAX | |
| A | 0.85 | 0. 95 | 1.00 | 0.033 | 0.037 | 0.039 | |
| A1 | 0.00 | | 0.05 | 0.000 | | 0.002 | |
| b | 0.30 | 0.40 | 0.50 | 0.012 | 0.016 | 0.020 | |
| С | 0.15 | 0. 20 | 0. 25 | 0.006 | 0.008 | 0.010 | |
| D | 5. 10 | 5. 20 | 5. 30 | 0. 201 | 0. 205 | 0. 209 | |
| D1 | 4. 25 | 4. 35 | 4. 45 | 0. 167 | 0.171 | 0. 175 | |
| Е | 5. 45 | 5. 55 | 5.65 | 0. 215 | 0.219 | 0. 222 | |
| E1 | 5. 95 | 6.05 | 6. 15 | 0. 234 | 0. 238 | 0. 242 | |
| E2 | 3. 525 | 3.625 | 3. 725 | 0.139 | 0.143 | 0.147 | |
| E3 | 1. 175 | 1. 275 | 1. 375 | 0.046 | 0.050 | 0.054 | |
| e | 1. 27 BSC | | | 0.050 BSC | | | |
| L | 0.45 | 0. 55 | 0.65 | 0.018 | 0.022 | 0.026 | |
| L1 | 0 | | 0.15 | 0 | | 0.006 | |
| L2 | 0.68 REF | | | 0.027 REF | | | |
| θ | 0° | | 10° | 0° | | 10° | |

(SCALE 5:1)

NOTE

1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.

BOTTOM VIEW

2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

0.65

UNIT: mm



Din-Tek SEMICONDUCTOR

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